

**Notice of References Cited**

Application/Control No.

10/812,532

Applicant(s)/Patent Under  
Reexamination  
ZHU, WEIWEN

Examiner

SAEED S. MIRZADEGAN

Art Unit

2144

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,848,415 A	12-1998	Guck, Randal Lee	707/10
*	B	US-2002/0184527 A1	12-2002	Chun et al.	713/201
*	C	US-2003/0163569 A1	08-2003	Panasyuk et al.	709/227
*	D	US-2003/0214943 A1	11-2003	Engstrom et al.	370/353
*	E	US-2003/0236978 A1	12-2003	Evans et al.	713/164
*	F	US-2003/0228866 A1	12-2003	Pezeshki, Farhad	455/422.1
*	G	US-2003/0236890 A1	12-2003	Hurwitz et al.	709/227
*	H	US-2004/0006725 A1	01-2004	Lakshmanamurthy et al.	714/42
*	I	US-2004/0016000 A1	01-2004	Zhang et al.	725/143
*	J	US-2004/0019693 A1	01-2004	Grow et al.	709/232
*	K	US-2004/0019689 A1	01-2004	Fan, Kan Frankie	709/230
*	L	US-2004/0032881 A1	02-2004	Arai, Kanehide	370/466
*	M	US-2004/0170155 A1	09-2004	Omar et al.	370/349

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
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	X					

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0044016 A1	02-2005	Irwin et al.	705/030
*	B	US-2005/0044388 A1	02-2005	Brant et al.	713/186
*	C	US-2005/0071280 A1	03-2005	Irwin et al.	705/059
*	D	US-7,020,685 B1	03-2006	Chen et al.	709/204
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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	Q					
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